U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY. DOCKET NO. SURR.30 SERIAL NO. 09/688,063 FORM PTO-1449 APPLICANT NATAN ET AL. LIST OF INFORMATION CITED BY APPLICANT Page 1 of 3 GROUP FILING DATE 10/13/2000

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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered.				

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